

R3754A/3754B New Network Analyzer

New Network Analyzer Released with Exceptional Cost/Performance!







As reduced cost, downsizing, precision improvement, and power consumption reduction have advanced for information communication equipment and multimedia equipment, the high-frequency components used for them require new technology.

For test inspection of these parts, a unit capable of high accuracy, high reliability measurements is necessary to enable throughput improvement, price reduction, automation, including the test fixture, and basic performance improvement.

The Advantest network analyzer provides test cost reduction as well as offering the measurement solution. The R3754 Series is a high performance network analyzer with greatly enhanced functional performance and a low price.

## **Optimization for Each Application**

Optimization has been made by setting the measurement frequency range to the limited bandwidth of 10 kHz to 150 MHz. The R3754 Series can be used for adjustment and test in the production and inspection processes of crystal, ceramic, LC, and sensor parts. Two types of display units are selectable according to the application. It is recommended to use the R3754A with monochrome display for the pre-process and the R3754B with color display for shipment inspection and receiving inspection.

## Doubled Maximum Sweep Speed and High Throughput

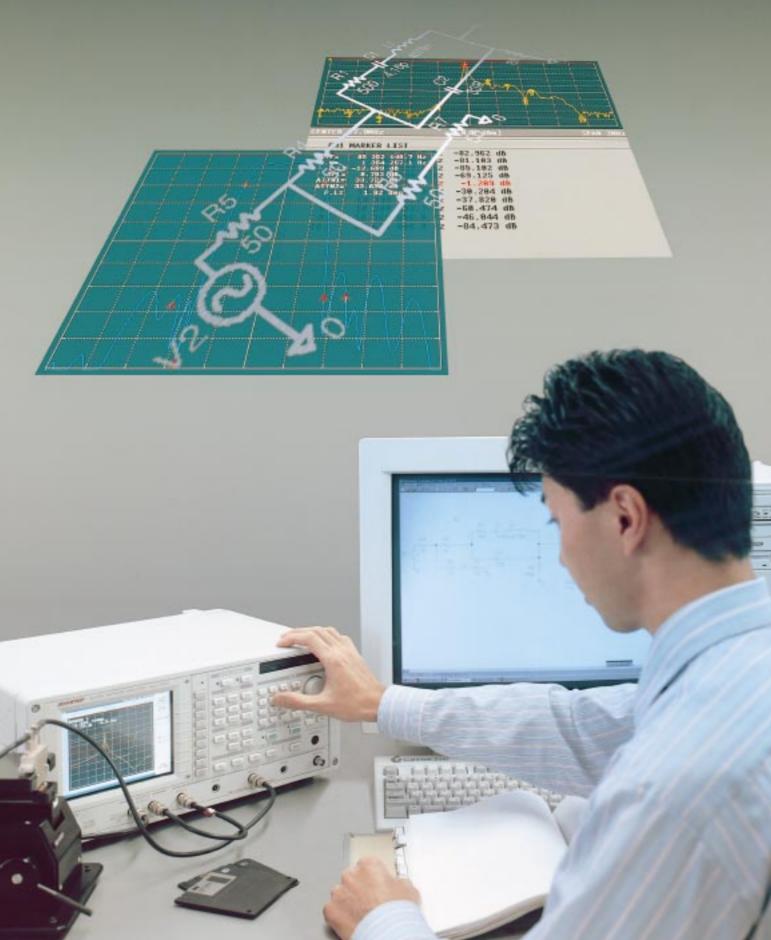
Advantest in the R3754 has doubled the sweep speed in comparison to our previous model. The newly developed measurement algorithm greatly improves the total throughput. The improved noise floor and increased maximum input level create a measurement dynamic range of 127 dB (a 13 dB increased over the previous model). It is possible to measure the high attenuation filter at high speed. A 15 dB improvement in the C/N suppress the trace noise and enhance the throughput and basic performance. Fluctuation in the trace has been reduced to 1/5 the amount in previous instruments. The required time to achieve the specification-guaranteed stabilization from power-on has also been reduced to 1/3.

## Self-diagnostic Function Minimizing Down Time

The attitude of Advantest is: if the unit should have a fault, how is it possible to reduce the down time of the production line? One of the answers is the self-diagnostic function. The R3754 series is loaded with a powerful self-diagnostic function. Advantest's position is that in the event that any failure occurs, downtime must be minimized.



# AMAZING COST/PERFORMANCE ACHIEVED



# Sweep Speed 0.05 ms/point and Dynamic Range 127 dB Achieved

## Excellent basic performance (1)

Sweep time: 50 µs/point (2 times faster in comparison to previous Advantest model)

RBW step value: 27 steps (3 times more in comparison to previous Advantest model)

## Excellent basic performance (2)

Noise floor: -122dBm (7 dB improved in comparison to previous Advantest model)

Trace noise: typ. -0.0015dB (2 times improved in comparison to previous Advantest model)

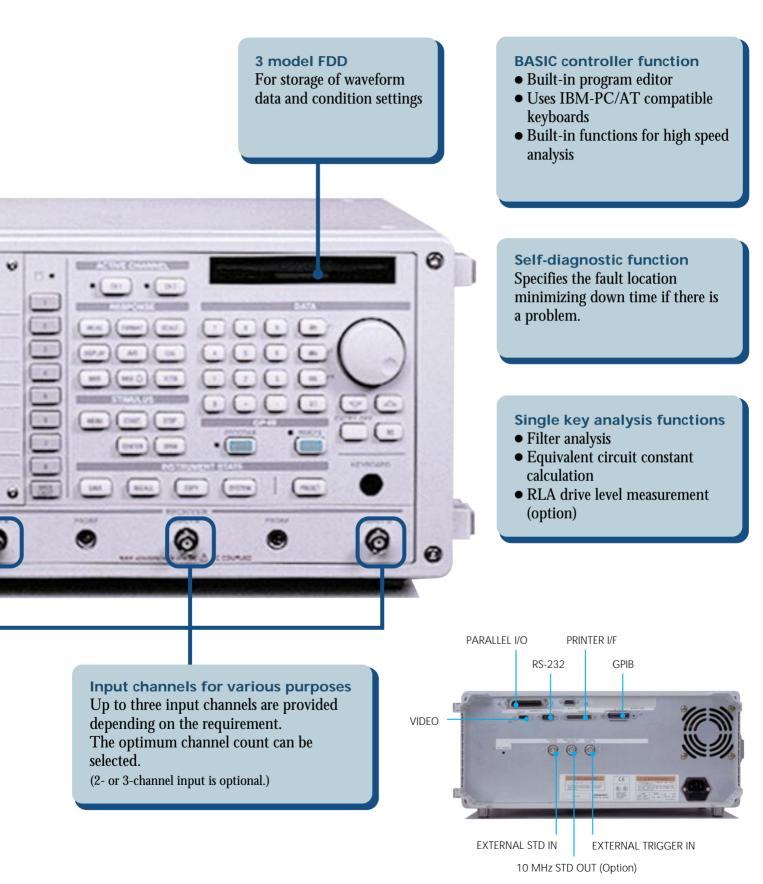
Stability: typ. -0.02dB/°C (2 times improved in comparison to previous Advantest model) 6.5-inch color TFT LCD
\* 5-inch monochrome LCD is used in type A



R3754B

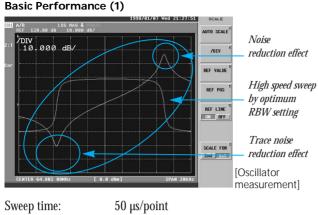


R3754A (5-inch STN monochrome LCD)



**REAR PANEL** 

## **Excellent Basic Performance**



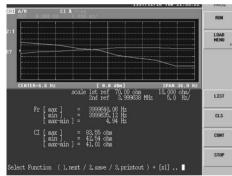
(2 times faster in comparison by Advantest) No. of RBW variables: 27 steps

(3 times more in comparison by Advantest)

The basic performance relating to the measurement speed has been greatly improved. The measurement conditions suitable for the device are further optimized to achieve compatibility of high-speed and high-stability measurements.

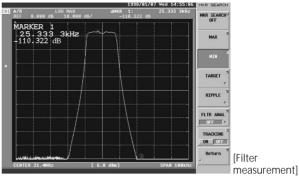
## **Measurement Efficiency Improvement by New Functions**

RLA drive level measurement (Option 71)



The drive level measurement function in the Reactance Linear Approximation method (RLA method) allows highspeed, high-accuracy measurement of the crystal impedance and the resonance frequency fluctuation at only two points per level. This function enables quantum improvement of the throughput in the drive level measurement process. (Option 71)

## Basic Performance (2)



Noise floor: -122 dBm

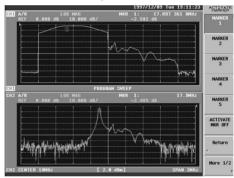
(7 dB improved in comparison to previous Advantest model) Trace noise:typ. -0.0015 dB  $\,$ 

(2 times improved in comparison to previous Advantest model) Stability: typ. -0.02 dB°C

(2 times improved in comparison to previous Advantest model) Measurement stability has been greatly improved.

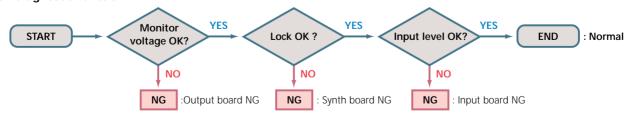
A device with severe measurement conditions can be stably measured without decreasing the measurement speed.

### Gate ON/OFF comparison measurement



The filter analysis function has been enhanced and the operability has been improved.

- Gate function:Analyzes the characteristics with multiple<br/>reflection canceled.Phase linearity:Phase linearity essential for the communi-<br/>cation interface filter characteristics can be
- analyzed at high speed. CDMA IF analysis: CDMA (IS-95) filters can be analyzed directly.
- TDR analysis: Multiple reflection can be analyzed on the time axis. (Option 70)



On the production line, equipment failures are grave problems.

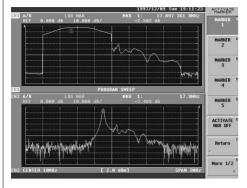
Advantest offers its products with warranties which take all possible measures to ensure product quality. However, if an

equipment failure occurs, it must be remedied as soon as possible. To reduce the recovery time, the R3754 series comes with a self-diagnostic function which allows you to minimize the downtime through quick location of failures.

## Self-diagnostic Function

## Suggestion of Test Cost Reduction by Speed Increase

Programmed sweep/segment-specified sweep



This function enables setting of optimal measurement conditions by allowing the segmentation of the swept frequency range. Up to 30 segments can be set for the span that include the frequency range, output level, and interface bandwidth, enhancing measurements for each device type. With use of the application software, it is possible to input the settings to commercially-available graphics software and perform the setup from the FD.

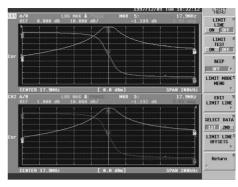
## High-speed Measurement (1)

Data transfer duration

(repetition of frequency setting, sweep, and data transfer)

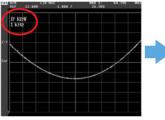
Sweep time is improved to  $50\mu$ s/point, two times faster (compared by Advantest). The data transfer duration is shortened to greatly improve the system throughput.

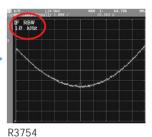
## 2-device simultaneous measurement



With use of the 3-channel input model (Option 11), the 2-channel/4-trace function enables 2-device simultaneous measurement. This improves the total throughput.

## High-speed Measurement (2)





Conventional RBW 1kHz 1ms/point

RBW 10kHz 0.1ms/point

Sweep time reduction and measurement stability improvement are a trade-off relationship. Basic performance improvement can reduce the sweep time with stability equivalent to the conventional.

## Extended Functions Suitable for System Use

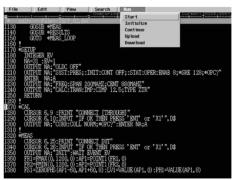
Design optimum for automation



Design has been made with assumption of incorporating an automated unit. It is possible to easily realize compatibility with any type of automation.

Parallel I/O (option)GPIB (standard)Printer (standard)VGA monitor output (standard)RS232 (standard)VGA monitor output (standard)

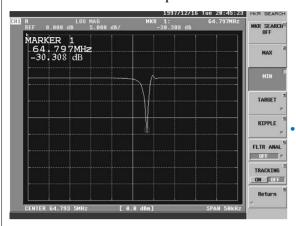
## BASIC controller function/program editor



Optimum to the system use because it is possible to establish an automated adjustment/inspection system without using an external computer. It is possible to use the built-in programming editor for programming as well as using a PC in the MS-DOS environment.

## Offers Optimal features for Measurements at Pre-process

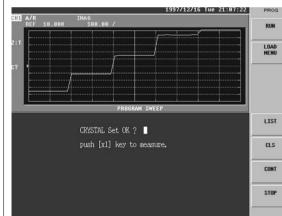
- High-speed, high-accuracy measurement with low noise (-122 dBm) Since non-contact measurements are made for blank selection, a crystal impedance (CI) increased, so that the influence of noise is readily appearant. It is then essential that the measuring unit has a low noise floor.
- High-speed fr measurement by the synchronous high-speed sweep search function The search execution function, which is synchronous with the sweep, further increases the measurement speed.



## Drive Level Characteristic Measurement (Option 71)

• High-speed and high-accuracy measurement through the RLA-based DLD measurement functions

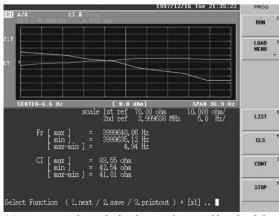
The Advantest method implements high-accuracy measurement without search error. The measurement range is from 0.5 nW to 500  $\mu$ W (varying with CI). Optimum measurement conditions are set according to the device type, improving the measurement speed.





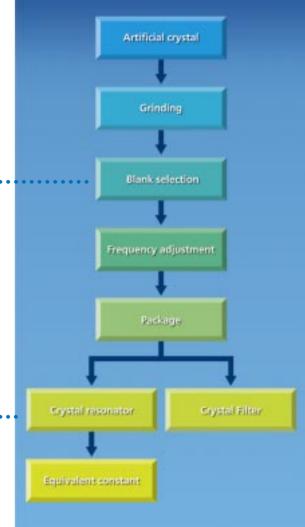
High-speed fr search applies the precise drive level resulting in high-speed measurement.

High-speed fr search waveform

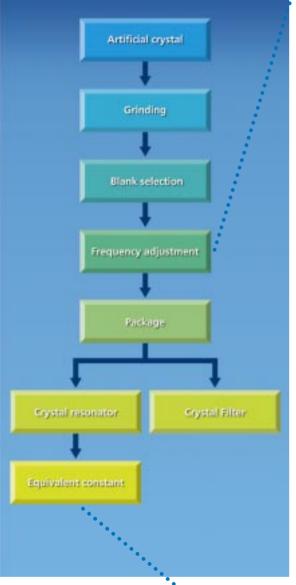


Measurement results are displayed as waveforms, enabling detailed analysis.

## Crystal device manufacturing process and network analyzer application



Crystal device manufacturing process and network analyzer application



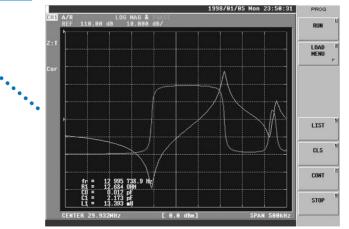
## Frequency Adjustment (Vacuum Evaporation)

- Frequency is adjusted at high speed with high precision by Advantest's frequency
- adjustment function.
- \* It is possible to update vacuum evaporators with a network analyzer. Contact Advantest for more information.



## **Equivalent Circuit Constant Analysis**

• Direct equivalent circuit constant analysis can greatly improve the analysis efficiency. Compatibility with the 4-elements and the 6-elements equivalent circuit can improve the development efficiency of automation software.



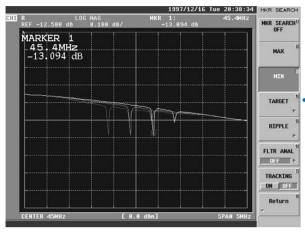
**Offers Optimal Features for Measurements at Pre-Process** 

the ceramic base.

• 50 µs/point high-speed sweep + synchronous high-speed sweep search (concurrent processing of measurement and search)

Resonance frequency check can be simultaneously performed in the grinding process.
Low noise (-122 dBm) implements high-accuracy measurement of high-impedance devices. High-speed, high-accuracy measurement can be performed for frequency selection of

• Direct filter analysis allows improvement of the measurement efficiency for frequency



and impedance at the resonant and anti-resonant points.

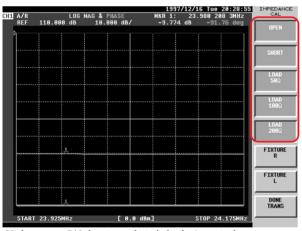
3-terminal resonator

Measurement of the 3-terminal Resonator with a Built-in Load Capacity (Option 72) • Dedicated high-precision calibration function

CAL kits of OPEN, SHORT, LOAD 50, LOAD 100 and LOAD 200 are available with the installed dedicated calibration algorithm.

The load capacity and the resonator characteristics excluding load capacity can be measured with high accuracy.

\* The R17041 test fixture and calibration kit are optional.

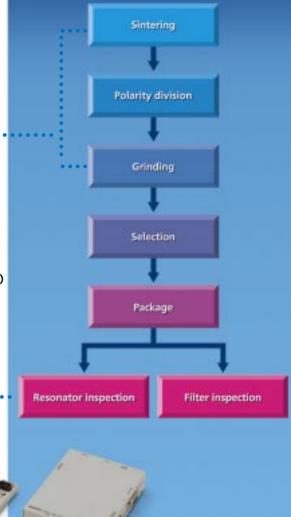


High-accuracy CAL function exclusively for the 3-terminal resonator

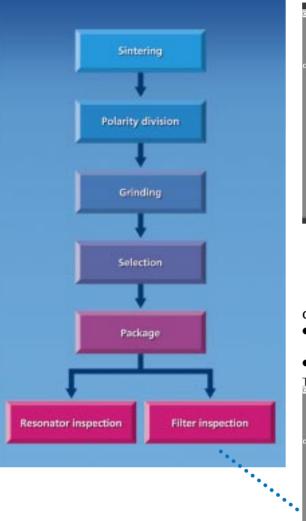
| or<br>C-HEASUF<br>C-high<br>C-low<br>CLEAR CA<br>DATA  | H1 A/R<br>REF 110.00 | LOG MAG & PHA<br>0 db 10.000 | SE MKR 1: | 07/12/16 Tue 2<br>23.980 208<br>I6 Ω 4.9 | 3MHz              |
|--|----------------------|------------------------------|-----------|--|-------------------|
| T<br>or<br>C-high<br>C-high<br>C-high<br>C-high<br>C-high  | C-high<br>14.839pF   |                              |           |  |                   |
| or<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-Hrasu<br>C-H |                      |                              |           | $\wedge$                                 | C-MEASURE         |
| C-high<br>C-low<br>CLEAR CA<br>DATA  | Т                    | $\int$                       |           | $\times$                                 | C-MEASURE         |
| C-Tow<br>CLEAR CA<br>DATA  | or                   | 4                            |           |  |                   |
|  |                      |                              |           | <u> </u>                                 | C-high            |
|  |                      | 1                            |           | 1  | C-10w             |
| Batura   |                      | V                            |           |  | CLEAR CAL<br>DATA |
| Neturn Neturn  |                      |                              |           |  | Return            |

<sup>3-</sup>terminal resonator measurement

## Ceramic device manufacturing process and network analyzer application

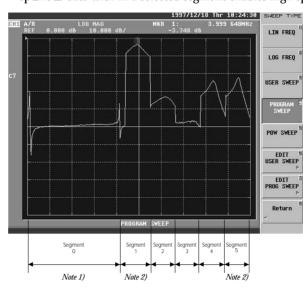


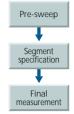
Ceramic device manufacturing process and network analyzer application



## Filter/Resonator Spurious Measurement

• User-specified segment measurement function Spurious measurements can be conducted over a wide band. Measurement of spurious data with in a selected segment enables high speed, high precision results.





#### Note 1)

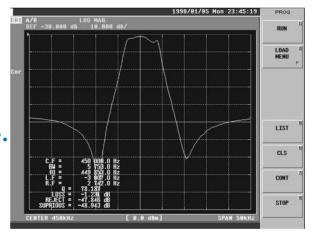
Only Segment 0 is swept. Sweep is executed at high speed to roughly measure the frequency of the primary oscillation or spurious emission.

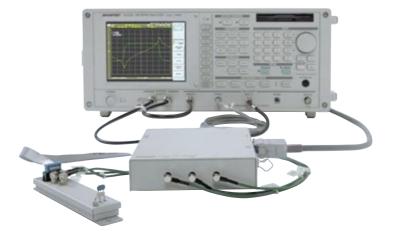
Note 2)

Based on the pre-sweep measurement result, segments included with in the measurement range are specified and the spurious emission is remeasured.

## **Ceramic Filter Measurement**

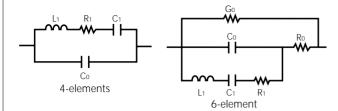
- Direct filter analysis function allows measuring all the filter characteristic items by a single-touch operation.
- Data transfer duration (repetition of frequency setting, sweep, and data transfer)





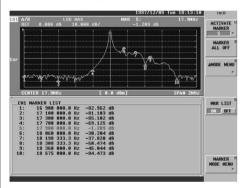
## **Excellent Operability**

**Direct Equivalent Circuit Constant Calculation Function** 



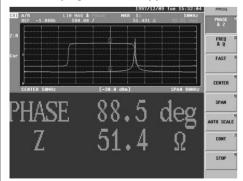
The resonator's equivalent circuit constant is directly measured. The 4-element and 6-element calculation functions are provided so that measurement results can be instantaneously obtained by direct operation in the manual mode. For automation, the software development efficiency is improved.

Multi-marker list

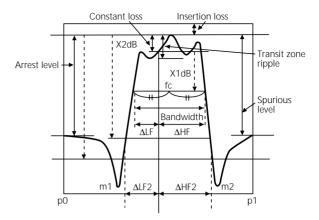


Up to 10 markers can be displayed for each channel. When large amount of information is required, as in the case of filter analysis, it is not necessary to change the marker positions which results in more efficient measurement.

### Zoom display function (application software)

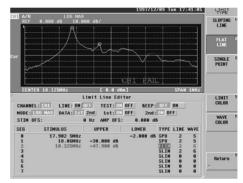


When it is necessary to make adjustments in a location at a distance from the measuring unit, the application software can be used to enlarge the displayed values. **Direct Filter Analysis Function** 



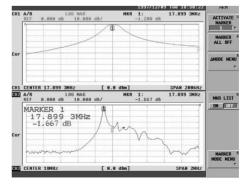
Filter characteristics can be measured directly. Measurement results can be instantaneously obtained in analysis of multiitem characteristics.

#### Limit line function



The standard value set with the limit line editor is judged for Pass/Fail. A beep can be sounded according to the judgment result or the result can be output to external equipment using the parallel I/O unit (Option 01). Also, use of the application software allows input of the set value for each device type to commercially-available graphics software and to make setup from FD.

## 256-color user edit



Production line operators look at the measuring unit screen for a long period of time. The ability to edit the screen colors helps to improve clarity and can also reduce eye strain.

## Ordering Information

## Main Unit

| Product Name | Main Unit                                 | Input Channel                | Remarks                                |
|--------------|---|------------------------------|--|
| R3754A       | 5-inch monochrome LCD                     | RCH                          | Additional input channels are optional |
| R3754B       | 6.5-inch color TFT LCD                    | RCH                          | Additional input channels are optional |
| Option       |   |                              |  |
| Option Code  | Function                                  | Remarks                      |  |
| 01           | Parallel I/O (R3753H compatible)          | Plus/minus logic chang       | je                                     |
| 02           | Parallel I/O                              | Pin assignment is chan       | iged                                   |
| 03           | Parallel I/O                              | Optical Isolation            |  |
| 10           | 2-ch input                                | RCH, ACH                     |  |
| 11           | 3-ch input                                | RCH, ACH, BCH                |  |
| 70           | TDR function                              | Time-axis waveform d         | isplay                                 |
| 71           | Drive level measurement function          | RLA method                   |  |
| 72           | 3-terminal resonator measurement function | R1704 and CAL Kit are        | required.                              |
| 90           | Japanese manual                           | Operation, Programmi         | ng Guide, Programming Manual           |
| 91           | English manual                            | Operation, Programmi         | ng Guide, Programming Manual           |
| Aggesory     |   | * The operating manual is op | ptional.                               |

#### Accessory

| Product Name                     | Model Name              | Remarks                                      |  |
|----------------------------------|-------------------------|--|--|
| Fixture for 3ports measurement   | R17041                  | Consists of the test fixture and switch box. |  |
| Crystal Test Adapter             | A07010                  | $\pi$ circuit applicable to SMD              |  |
| Crystal Test Adapter             | A07011                  | $\pi$ circuit applicable to the read type    |  |
| Reflection bridge                | A17020 Series           | 100Hz to 1MHz                                |  |
| Impedance conversion transformer | R17000 Series           | 100Hz to 1MHz                                |  |
| Power splitter                   | VCR-111 (Tama Electric) | 3-branch                                     |  |
| Active probe                     | AP003 (Stack Electric)  | DC to 1000MHz FET probe                      |  |
| Rack mount set                   | · · · ·                 |  |  |
| Rail set                         |                         |  |  |

## **Crystal Test Adapter**

## Main unit A07001 \*1

| Applicable Device | Change Kit | CAL Kit   | π Circuit / | Adapter *2                                    |
|-------------------|------------|-----------|-------------|---|
|                   |            |           | Normal type | With built-in variable load capacity function |
| TSX-1             | A07003-01  | A07004-01 | A07002-01   | A07007-01                                     |
| TSX-2             | A07003-02  | A07004-02 | A07002-02   | A07007-02                                     |
| CP21B             | A07003-03  | A07004-03 | A07002-03   | A07007-03                                     |
| CX-89F2           | A07003-04  | A07004-04 | A07002-04   | A07007-04                                     |
| CX-91F            | A07003-05  | A07004-05 | A07002-05   | A07007-05                                     |
| DSX631            | A07003-06  | A07004-06 | A07002-06   | A07007-06                                     |
| DSX751            | A07003-07  | A07004-07 | A07002-07   | A07007-07                                     |
| JIS43             | A07003-08  | A07004-08 | A07002-08   | A07007-08                                     |
| JIS03             | A07003-09  | A07004-09 | A07002-09   | A07007-09                                     |

| Name          | Model     | Capacity    |
|---------------|-----------|-------------|
| Load capacity | A07005-01 | 5pF         |
|               | A07005-02 | 10pF        |
|               | A07005-03 | 15pF        |
|               | A07005-04 | 20pF        |
|               | A07005-05 | 25pF        |
|               | A07005-06 | 30pF        |
| Contact pin   | A07006    | 10-pins/set |

| *1: Select the main unit, the change kit, the CAL kit, and the adapter |
|--|
| as a set.  |

\*2: Select either the normal adapter or the adapter with the variable load capacity function built in.



Crystal Test Adapter A07001 to A07007



Crystal Test Adapter A07010



3ports ceramic resonator fixture to A07008

| Measurement Function                                  |  | Input characteristics                      |   |
|---|--|--|---|
| Measurement channel:                                  | 2 channels (4-trace display)   | Input channel:                             | 1 ch, 2 ch (Option 10), 3ch (Option 11)   |
|   | R  | Frequency range:                           | 10 kHz to 150 MHz   |
| Measurement parameter:                                | A/R, R, A (Option 10)  | Impedance:<br>Return loss:                 | Nominal 50 $\Omega$<br>ATT 0 dB 20 dB or more                                   |
|   | A/R, B/R, A/B, R, A, B (Option 11)   |  | ATT 25 dB 25 dB or more   |
| Measurement format                                    |  | Max. input level:                          | ATT 25 dB AMP 0 dB +5 dBm   |
| AC/DC display:  | Logarithmic/linear amplitude, phase, group   |  | ATT 0 dB AMP 0 dB -20 dBm<br>ATT 0 dB AMP 16 dB -36 dBm                         |
|   | delay, real and imaginary portions of<br>complex number parameters                     | Input destruction level:                   | +24 dBm, ±3 VDC   |
|   | Z, R, X (impedance conversion measurement)   | Average noise level:                       | RBW 10 kHz 200 kHz to 500 kHz -102 dBm  |
|   | Y, G, B (admittance conversion measurement)  | (ATT 0 dB, AMP 16 dB)                      | 500 kHz to 150 MHz -112 dBm   |
|   | Phase extension display  |  | RBW 3 kHz 60 kHz to 500 kHz -107 dBm  |
| Smith chart:  | Logarithmic/linear amplitude and phase for   |  | 500 kHz to 150 MHz -117 dBm   |
| Smith chart.  | marker reading, real and imaginary portions,   |  | RBW 1 kHz 20 kHz to 500 kHz -112 dBm  |
|   | R+jX, G+jB   |  | 500 kHz to 150 MHz -122 dBm   |
|   | · ·  |  | RBW 300 Hz 10 kHz to 500 kHz -117 dBm<br>500 kHz to 150 MHz -127 dBm            |
| Polar coordinates display:                            | Logarithmic/linear amplitude and phase for marker reading, real and imaginary portions | Resolution bandwidth                       | 500 KHZ 10 150 MHZ -127 UBI   |
|   | marker reading, rear and imaginary portions  | (RBW):                                     | 3 Hz to 15 kHz (1, 1.5, 2, 3, 4, 5, or 7 steps)                                 |
|   |  | Input cross-talk:                          | 10 kHz to 500 kHz 105 dB  |
| Signal Source Characteris                             | tics (23 ±5°C)   | • • • • • • • • •                          | 500 kHz to 150 MHz 120 dB   |
| Frequency characteristics                             |  | Signal source cross talk:                  | 10 kHz to 500 kHz 105 dB  |
| Range:  | 10 kHz to 150 MHz  |  | 500 kHz to 150 MHz 120 dB   |
| Resolution:   | 0.1 Hz   | Input connector:                           | BNC (female) 50 $\Omega$  |
| Accuracy:   | ±5 ppm (Typ.)  | Automatic offset correction                |   |
|   | ±1 ppm (Option 20)*  | Normalization function:                    | Compensates the frequency characteristics of                                    |
|   | (1 MHz or more, when 0 to +50°C,<br>after 30 minutes warm-up)                          |  | the measurement system.   |
| Stability:  | $\pm 2 \times 10^{-8}$ /day (Option 20)*   | Electric length correction:                | Equivalent electric length or group delay                                       |
| stability.  | (after 48 hours warm-up)   |  | time can be added to the measured phase or                                      |
|   | (p)  | <b>D</b>                                   | group delay time.   |
| Output characteristics                                | 21 dDm to 12 dDm   | Range:                                     | -3 X 10 <sup>s</sup> m to +3 X 10 <sup>s</sup> m or +10 sec. to -10 sec.        |
| Output characteristics:<br>Resolution:                | +21 dBm to -43 dBm<br>0.1 dB   | Amplitude characteristics                  |   |
| Accuracy:   | ±0.5 dB (0 dBm, 10 MHz)  | (absolute characteristics)                 |   |
| Linearity (50 MHz):                                   | +21 dBm to -35 dBm ±0.5 dB   | Measurement range:                         | ATT AUTO AMP 0 dB +5 dBm to -115 dBm  |
|   | -35 dBm to -43 dBm ±1.5 dB   | (RBW 1 kHz)                                | ATT 25 dB AMP 0 dB +5 dBm to -90 dBm  |
| Flatness (at 0 dBm output):                           | 10 kHz to 300 kHz ±2.0 dB  | (100 kHz or more)                          | ATT 0 dB AMP 0 dB -20 dBm to -115 dBm<br>ATT 0 dB AMP 16 dB -36 dBm to -122 dBm |
|   | 300 kHz to 150 MHz ±1.5 dB   | Display resolution:                        | 0.001 dB/div  |
| Impedance (output port 1):                            | Nominal 50 Ω   | Accuracy:                                  | ±0.5 dB (10 MHz, max. input level)  |
|   | Return loss 13 dB or more  | Frequency response                         |   |
|   | (at 0 dBm output, Typ.)  | (at 0 dBm input):                          | 10 kHz to 1 MHz 4 dBp-p   |
| Signal purity   |  |  | 1 MHz to 150 MHz 3.5 dBp-p  |
| Harmonic wave distortion:                             |  | Dynamic accuracy:                          | 0 to -10 dBm ±0.4 dB  |
| •   | : <-20 dBc or -60 dBm, whichever is larger   | (ATT 25 dBm, AMP 0 dB)                     | -10 to -60 dBm ±0.1 dB  |
| Phase noise:  | ≤-95 dBc/Hz (10 kHz offset)  | (100 kHz or more)                          | -60 to -70 dBm ±0.2 dB<br>-70 to -80 dBm ±0.6 dB                                |
| Sweep characteristics                                 |  |  | 170 to -00 dbin 10.0 db   |
| Sweep parameter:                                      | Frequency, signal level  | Amplitude characteristics                  |   |
| Range:  | Same as the frequency sweep frequency  | (relative characteristics):                | Option 10, Option 11  |
|   | characteristic<br>Level sweep +21 dBm to -43 dBm                                       | Measurement range:<br>ATT 25 dB AMP 0 dB   | ATT AUTO AMP 0 dB ±120 dB<br>ATT 20 dB AMP 0 dB ±95 dB                          |
|   | •  | (100 kHz or more)                          | ATT 0 dB AMP 0 dB ±95 dB  |
| Range setting:  | Start/Stop or Center/Span  | (  | ATT 0 dB AMP 16 dB ±86 dB   |
| Sweep type:   | Linear/logarithmic frequency sweep, level  | Display resolution:                        | 0.001 dB/div  |
|   | sweep, sweep of a user-defined segment   | Accuracy:                                  | ±0.5 dB (10 MHz, max. input level)  |
| Sweep time:   | Max. 0.05 ms/point (RBW 15 kHz)  | Frequency response:                        | 10 kHz to 1MHz 3 dBp-p  |
|   | • • •  | (at 0 dBm input)                           | 1 MHz to 150 MHz 2 dBp-p  |
| Measurement point:                                    | 3, 6, 11, 21, 51, 101, 201, 301, 401, 501, 601,  | Dynamic accuracy:                          | 0 to -10 dBm ±0.1 dB  |
|   | or 1201 points   | (ATT 25 dB, AMP 0 dB)<br>(100 kHz or more) | -10 to -60 dBm ±0.05 dB<br>-60 to -70 dBm ±0.1 dB                               |
| Sweep trigger:  | Continuous, Single, External   | (TOU KITE OF HIDLE)                        | -70 to -80 dBm ±0.1 dB  |
| Sweep mode:   | Dual sweep (2-channel sweep in the same  |  | -80 to -90 dBm ±0.9 dB  |
|   | frequency range),  |  |   |
|   | alternate sweep (2-channel sweep in  | Phase characteristics (relativ             |   |
|   | different frequency ranges)  | Measurement range:                         | ±180 <sup>°</sup><br>Continuous display possible for more than                  |
| Output form   |  |  | ±180° by the display expansion function   |
| Output:   | Single   | Resolution:                                | 0.01  |
|   | Single, dual (Option 10, Option 11)  | Dynamic accuracy:                          | 0 to -10 dBm ±3.0   |
| Connector:  | BNC (female), 50 $\Omega$  | (ATT 25 dB, AMP 0 dB)                      | -10 to -50 dBm ±1.5   |
| Power splitter  | ·  | (100 kHz or more)                          | -50 to -60 dBm ±2.0   |
| Power splitter<br>(output port 2):                    | Option 10, Option 11   |  | -60 to -70 dBm ±2.4°  |
| <u>· · · · ·</u>                                      | • • •  |  | -70 to -80 dBm ±3.6   |
| Insertion loss :                                      | 6 dB (Typ.)  | ** With a measurement range sett           | ing which includes 32.5 MHz, absolute measured phase                            |
| (Option 10, Option 11)                                |  | characteristic values for are not          |   |
| Level tracking :                                      | <100 MHz 0.1 dB (Typ.)   |  | unit is used with a measurement range setting between                           |
| (Option 10, Option 11)                                | ≥100 MHz 0.2 dB (Typ.)   | 10 kHz and 32.5 MHz, or betv               |   |
| Equivalent output SWB :                               | <100 MHz 1.2 (Typ.)  |  |   |
|   |  |  |   |
| (Option 10, Option 11)<br>*RNC RNC mbla (A01026 0150) | ≥100 MHz 1.4 (Typ.)  |  |   |

\*BNC-BNC cable (A01036-0150) will be attached.

| Phase characteristics (relative)<br>Measurement range:  | ±180°<br>Continuous display poss<br>±180 deg. by the display   |   |
|---|--|---|
| Resolution:   | function<br>0.01 <sup>°</sup>  |   |
| Frequency response :  | 10 kHz to 1 MHz  | 20 <sup>°</sup> p-p   |
| (at 0 dBm input)  | 1 MHz to 150 MHz   | 15 <sup>°</sup> p-p   |
| Dynamic accuracy:   | 0 to -10 dBm   | ±1.0 <sup>°</sup>   |
| (ATT 25 dB, AMP 0 dB)   | -10 to -50 dBm   | ±0.3 <sup>°</sup>   |
| (100 kHz or more)   | -50 to -60 dBm   | ±0.5°   |
|   | -60 to -70 dBm<br>-70 to -80 dBm   | ±1.0 <sup>°</sup><br>±3.0 <sup>°</sup>  |
|   | -80 to -90 dBm   | ±3.0<br>±8.0 <sup>°</sup>   |
| Delay characteristics   |  |   |
| Range:  | Calculated using the foll<br>$r = \frac{\Delta \emptyset}{360 \text{ X} \Delta f} \frac{\Delta \emptyset}{\Delta f}$ : Phase   |   |
| Measurement range:<br>Group delay time resolution:  | 1 ps to 250 s<br>1 ps  | ine mequency (mz)   |
| Aperture frequency:   | Equivalent to ∆f   |   |
|   | 100 X 2%   | With this resolution,<br>it is possible to set  |
|   | Measurement point - 1  | from this value   |
|   | 100 X 2%   | through about 100%  |
| •   | Measurement point - 1  | of the frequency spa  |
| Accuracy:   | Phase accuracy<br>360 X Aperture frequence   | <u>rv (Hz)</u>  |
|   | 300 A Aperture frequence   | Jy (ПZ)   |
| Error correction functions<br>Normalization:  | Corrects the frequency   | asponso (amplitud   |
| Normalization.  | Corrects the frequency r<br>phase) during transfer n   | esponse (amplitud<br>neasurement  |
| 1-port calibration:   | Corrects the bridge dire   | ction, the frequenc   |
| 1   | response, and the source   |   |
|   | Error correction requires  |   |
|   | Load.  | •   |
| Data averaging:   | Averages data (vector v  | alues) for each   |
|   | sweep.   |   |
|   | Averaging count can be   | set from 2 to 999.  |
| Transfer full calibration:  | High accuracy measuren   | nent possible using   |
|   | 1  |   |
|   | transfer normalization in  | n transfer  |
|   | transfer normalization in measurement. Error cor   | n transfer  |
|   | transfer normalization in  | n transfer  |
| Connection with External  | transfer normalization in<br>measurement. Error cor<br>Short and Load.   | n transfer  |
| Connection with External  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment  | n transfer<br>rection requires  |
| External display signal output  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment  | n transfer<br>rection requires  |
| External display signal output<br>GPIB data output and  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector  | n transfer<br>rection requires  |
| External display signal output<br>GPIB data output and<br>remote control:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488  | n transfer<br>rection requires  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub  | n transfer<br>rection requires  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232   | n transfer<br>rection requires  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub  | n transfer<br>rection requires  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible   | n transfer<br>rection requires<br>(VGA)   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) o<br>TTL level, 8-bit output (2  | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)  | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) o<br>TTL level, 8-bit output (2  | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)  | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)<br>External trigger signal input:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)<br>External trigger signal input:<br>Display Section  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V<br>BNC connector (female)   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more<br>2 ports),  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)<br>External trigger signal input:<br>Display Section<br>Display unit:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V<br>BNC connector (female)<br>R3754A 5-inch STN mon-<br>R3754B 6.5-inch color TF   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more<br>2 ports),<br>2 ports),   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)<br>External trigger signal input:<br>Display Section<br>Display unit:<br>Resolution:  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V<br>BNC connector (female)<br>R3754A 5-inch STN mon<br>R3754B 6.5-inch color TF<br>640 X 640 dots  | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>2r more<br>2 ports),<br>2 ports),<br>0 chrome LCD<br>T LCD  |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)<br>External trigger signal input:<br>Display Section<br>Display unit:   | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V<br>BNC connector (female)<br>R3754A 5-inch STN mon<br>R3754B 6.5-inch color TF<br>640 X 640 dots<br>AC-DC logarithmic/linea   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more<br>2 ports),<br>2 ports),<br>0 cohrome LCD<br>T LCD<br>r coordinates,   |
| External display signal output<br>GPIB data output and<br>remote control:<br>Printer port:<br>Serial port:<br>Keyboard:<br>External reference<br>frequency input:<br>Parallel I/O output :<br>(Option 01)<br>Probe power:<br>(Option 10, Option 11)<br>External trigger signal input:<br>Display Section<br>Display unit:<br>Resolution:  | transfer normalization in<br>measurement. Error cor<br>Short and Load.<br>Equipment<br>: 15-pin D-sub connector<br>Conforming to IEEE 488<br>25-pin D-sub<br>Based on RS-232<br>IBM-PC/AT compatible<br>Available frequencies 1,<br>±10 ppm, 0 dBm (50 Ω) of<br>TTL level, 8-bit output (2<br>4-bit I/O (2 ports)<br>±12 V<br>BNC connector (female)<br>R3754A 5-inch STN mon<br>R3754B 6.5-inch color TF<br>640 X 640 dots<br>AC-DC logarithmic/linea<br>polar coordinates, Smith   | n transfer<br>rection requires<br>(VGA)<br>2, 5 and 10 MHz<br>or more<br>2 ports),<br>2 ports),<br>0 chrome LCD<br>T LCD<br>r coordinates,<br>n chart   |
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| Auto scale:                | The optimum reference level and scale value<br>are automatically set for the current<br>measurement.   |
|----------------------------|--|
| Backlight:                 | ON/OFF, no adjustment for the R3754A   |
| Contrast:                  | Contrast control provided for R3754A   |
| Marker Functions           |  |
| Marker display:            | Marker readings can be converted to display<br>values corresponding to the respective<br>measurement formats.  |
| Multi-marker:              | 10 individual markers can be set for each channel.   |
| Delta marker:              | Any of the10 markers can be specified as the reference marker enabling delta value measurements between markers.   |
| Marker couple:             | Markers of each channel can be set in coupled or independent form.   |
| Specific section analysis: | Marker search possible for a section specified by the delta marker.  |
| MKR search:                | MAX search, MIN search, NEXT search  |
| Marker track:              | Search is performed for each sweep.  |
| Target search:             | It is possible to calculate the bandwidth, center frequency, Q at the X dB down point. It is also possible to search the phase 0 degree frequency value and the $\pm X^{*}$ frequency width. deg. frequency width. |
| MKR→:                      | MKR→Reference value, MKR→START,<br>MKR→STOP, MKR→CENTER  |
| Limit line function:       | Limit line can be set for up to 31 segments.<br>Pass/Fail judgments can be performed for each<br>segment.  |
| Direct analysis function:  | Resonator analysis, etc.   |
| Instrument State Funct     | tions  |
| Save register:             | Allows storing condition settings and CAL data in battery backed internal memory.  |
| Data save/recall:          | Allows storing/loading data to/from FDD  |
| Programming Functior       | IS   |
| BASIC control function:    | Standard control function allows the control<br>of the main unit as well as other measurement<br>equipment with the GPIB interface.  |
| Built-in functions:        | Allows high-speed analysis of measurement data.  |
| FDD function:              | Based on the MS-DOS format FD.<br>Storage capacity<br>(DD: 720 Kbytes, HD: 1.2 Mbytes, 1.44 Mbytes)  |
| General Specifications     |  |
| Operating environment      |  |
| FDD used:                  | Temperature range +5 to +40°C,<br>humidity range 80% or less (no condensation)   |
| No FDD used:               | Temperature range 0 to +50°C,<br>humidity range 80% or less (no condensation)<br>-20°C to +60°C  |
| Storage environment:       | 100 VAC to 120 VAC, 220 VAC to 240 VAC,  |
| Power supply:              | 48 Hz to 66 Hz, 100 VAC and 200 VAC systems<br>are automatically changed.  |
| Bower consumption:         | 200 VA or less   |
| Power consumption:         | 200 VA OF less   |
| External dimensions:       | Approx. 424 (W) X 177 (H) X 300 (D)  |
|                            |  |

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